Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,985	TANIKAWA ET AL.	
Examiner	Art Unit	_
John T. Kwon	3747	

	SEARCHED				
Class	Subclass	Date	Examiner		
123	184.42	6/21/2005	JK		
	184.47				
	184.53				
	184.57				
	184.61				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
east	6/21/2005	JK		